## Notice of References Cited

Application/Control No. 10/615,794	Reexamination	olicant(s)/Patent Under examination DRICACOS ET AL.	
Examiner	Art Unit		
Nira S Rirenhaum Ph D	1742	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0108213	06-2004	Talasek et al.	205/081.
	В	US-6,749,739	06-2004	Chalyt et al.	205/788.5
	O	US-6,881,319	04-2005	Seita et al.	205/296
	D	US-6,083,374	07-2000	Kopp, Lorenz	205/101
	Ε	US-6,569,307	05-2003	Blachier et al.	205/82
	F	US-			·
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	. Name	Classification
	N					
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	Р	:				-
	Ø					
	R					
	S					
	Т	·				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Skoog, D.A.; West, D. M.; Holler, F.J. Fundamentals of Analytical Chemistry, 7th Ed. Saunders College Publishing, Forth Worth, 1996, pp. 701-703 and 708-709.
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.